## Notice of References Cited Application/Control No. 10/599,434 Examiner NATHAN H. EMPIE Applicant(s)/Patent Under Reexamination REETZ ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
	В	US-			
	С	US-			
	D	US-			
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## FOREIGN PATENT DOCUMENTS

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## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	James S. Reed "Principles of Cermics Processing" 2nd ed. (c)1995, John Wiley & Son, Inc NY, pg 69-71.
	V	
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	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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